
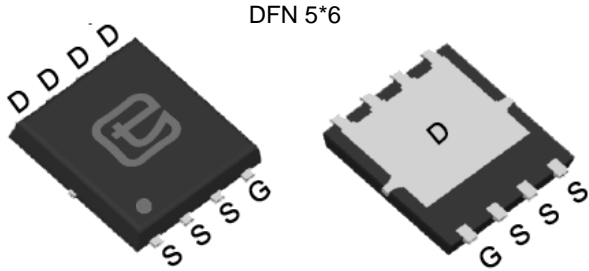
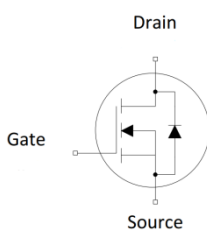


**100V N-Channel Trench MOSFET(Preliminary)**

General Description <ul style="list-style-type: none"> Trench Power Technology Low $R_{DS(ON)}$ Low Gate Charge Optimized for fast-switching Applications Applications <ul style="list-style-type: none"> Synchronous Rectification in DC/DC and AC/DC Converters Isolated DC/DC Converters in Telecom and Industrial 		Product Summary <table> <tr> <td>V_{DS}</td> <td>100V</td> </tr> <tr> <td>I_D (at $V_{GS}=10V$)</td> <td>65A</td> </tr> <tr> <td>$R_{DS(ON)}$ (at $V_{GS}=10V$)</td> <td>< 17mΩ</td> </tr> <tr> <td colspan="2">100% UIS Tested</td> </tr> </table> 		V_{DS}	100V	I_D (at $V_{GS}=10V$)	65A	$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 17m Ω	100% UIS Tested	
V_{DS}	100V										
I_D (at $V_{GS}=10V$)	65A										
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 17m Ω										
100% UIS Tested											
											
Device	Package	Form	Marking								
TTG65N10A	DFN5x6	Tape & Reel	65N10A								

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^{1B}	I_D	$T_C = 25^\circ\text{C}$	54
		$T_C = 100^\circ\text{C}$	45.5
Pulsed Drain Current ^A	I_{DM}	260	A
Avalanche Current ^A	I_{AS}	21	A
Single Pulse Avalanche Energy $L = 0.3\text{mH}$ ^A	E_{AS}	66	mJ
Power Dissipation ^C	P_D	$T_C = 25^\circ\text{C}$	200
		$T_C = 100^\circ\text{C}$	100
Operating Junction and Storage Temperature Range	T_J, T_{SGT}	-55 to 175	$^\circ\text{C}$

Thermal Resistance

Parameter	Symbol	Maximum	Units
Thermal Resistance, Junction-to-Case	R_{thJC}	0.75	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient	R_{thJA}	100	



Electrical Characteristics($T_J = 25^\circ\text{C}$ unless otherwise noted)							
Symbol	Parameter	Conditions	Value			Units	
			Min	Typ	Max		
STATIC PARAMETERS							
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	100	--	--	V	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 100\text{V}, V_{GS} = 0\text{V}$	$T_J = 25^\circ\text{C}$	--	--	1	μA
			$T_J = 100^\circ\text{C}$	--	--	25	
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	--	--	± 100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2	3	4	V	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{V}, I_D = 30\text{A}$	--	14	17	$\text{m}\Omega$	
g_{FS}	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 20\text{A}$	24	--	--	S	
V_{SD}	Diode Forward Voltage	$I_S = 20\text{A}, V_{GS} = 0\text{V}$	--	--	1	V	
I_S	Maximum Body-Diode Continuous Current ^B		--	--	65	A	
DYNAMIC PARAMETERS							
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 50\text{V}, f = 1\text{MHz}$	--	5523	--	pF	
C_{oss}	Output Capacitance		--	182	--		
C_{rss}	Reverse Transfer Capacitance		--	164	--		
SWITCHING PARAMETERS							
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS} = 10\text{V}, V_{DS} = 50\text{V}, I_D = 30\text{A}$	--	97	--	nC	
Q_{gs}	Gate Source Charge		--	26	--		
Q_{gd}	Gate Drain Charge		--	20	--		
$t_{D(on)}$	Turn-On Delay Time	$V_{GS} = 10\text{V}, V_{DS} = 40\text{V}, I_D = 30\text{A}, R_G = 2.5\Omega$	--	25	--	ns	
t_r	Turn-On Rise Time		--	20	--		
$T_{D(off)}$	Turn-Off Delay Time		--	73	--		
t_f	Turn-Off Fall Time		--	35	--		
t_{rr}	Body Diode Reverse Recovery Time	$I_F = 30\text{A}, di/dt = 100\text{A}/\mu\text{s}$	--	38	--	ns	
Q_{rr}	Body Diode Reverse Recovery Charge		--	60	--	nC	

A. Single pulse width limited by maximum junction temperature.

B. The maximum current rating is package limited.

C. The power dissipation P_D is based on $T_{J(MAX)} = 175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

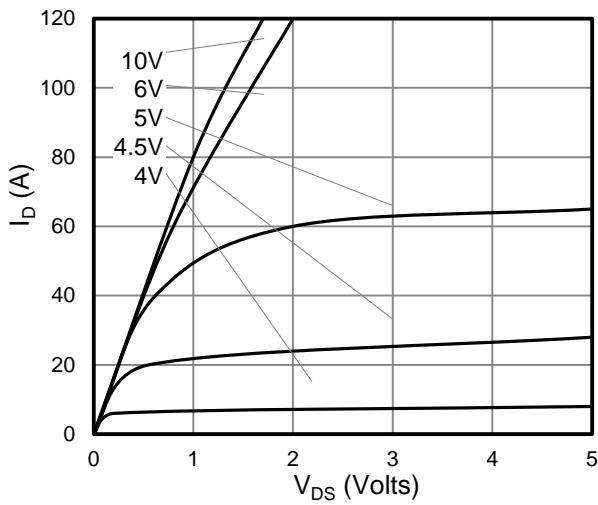


Figure 1: On-Region Characteristics

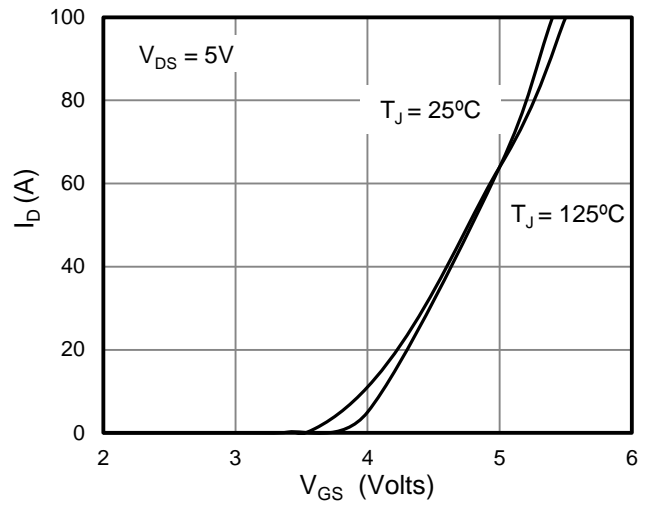


Figure 2: Transfer Characteristics

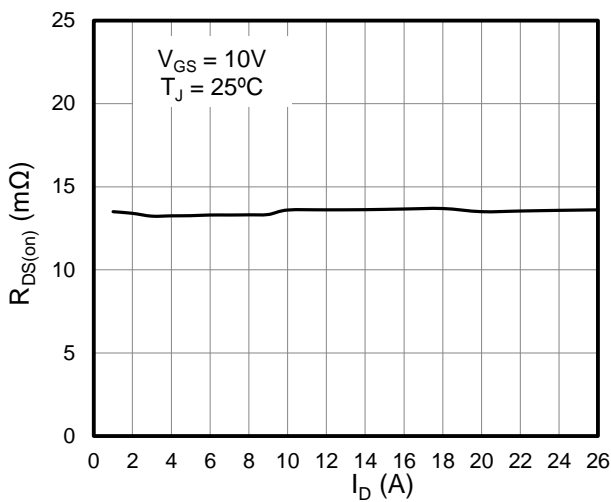


Figure 3: On-Resistance vs. Drain Current

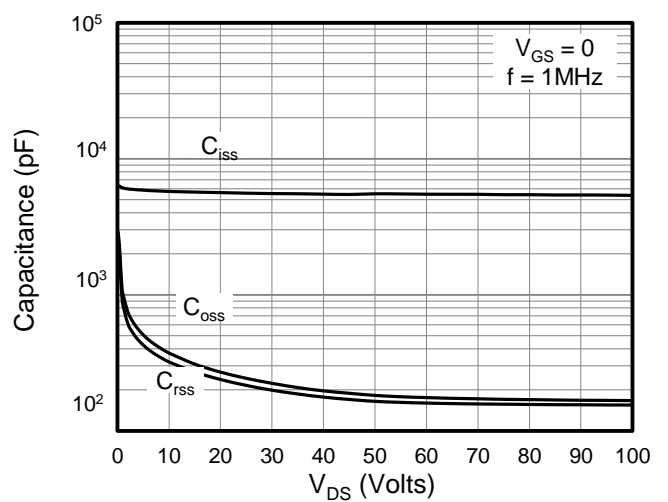


Figure 4: Capacitance Characteristics

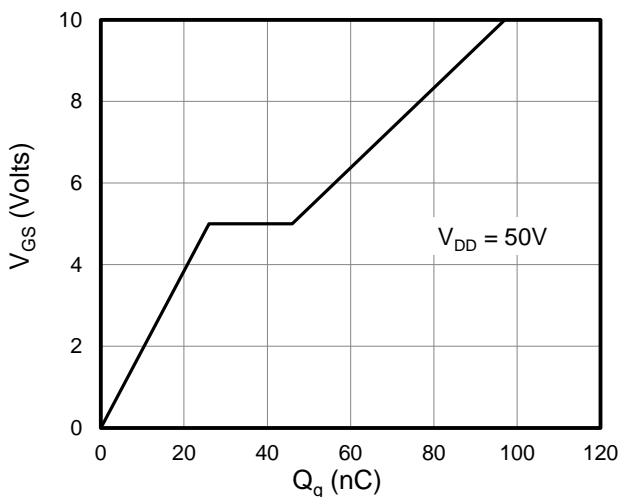


Figure 5: Gate Charge Characteristics

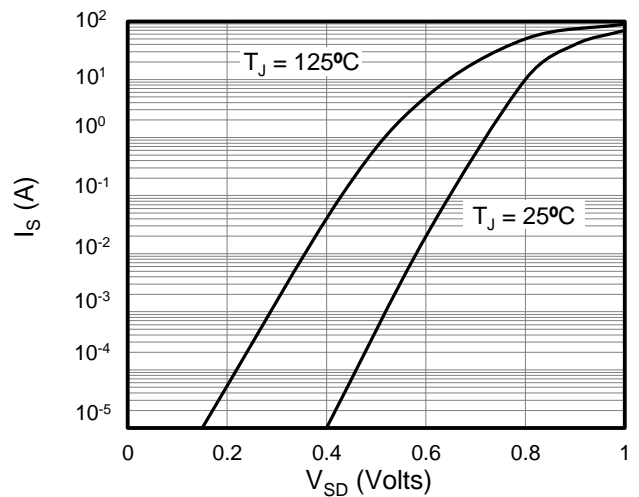


Figure 6: Body Diode Forward Voltage



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

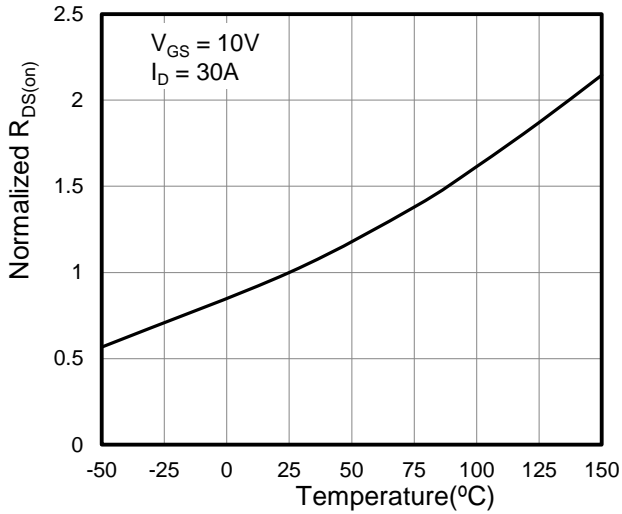


Figure 7: On-Resistance vs. Junction Temperature

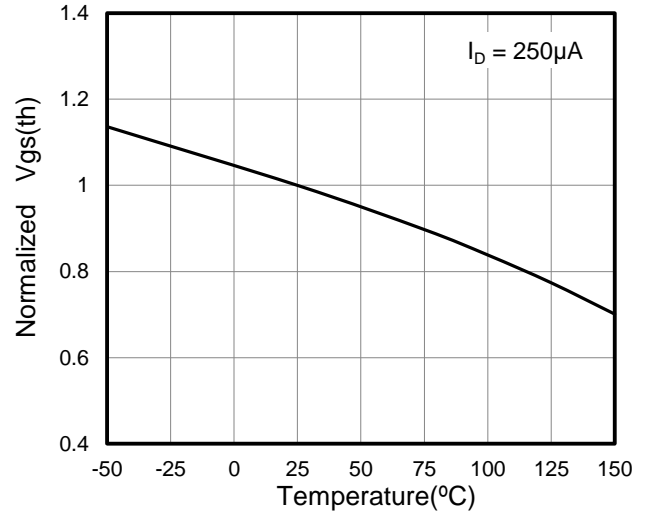


Figure 8: $V_{gs(th)}$ vs. Junction Temperature

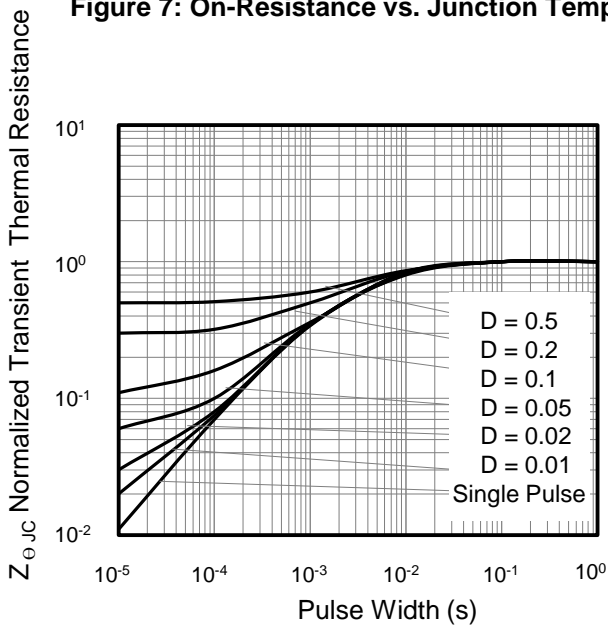


Figure 9: Normalized Transient Thermal Resistance

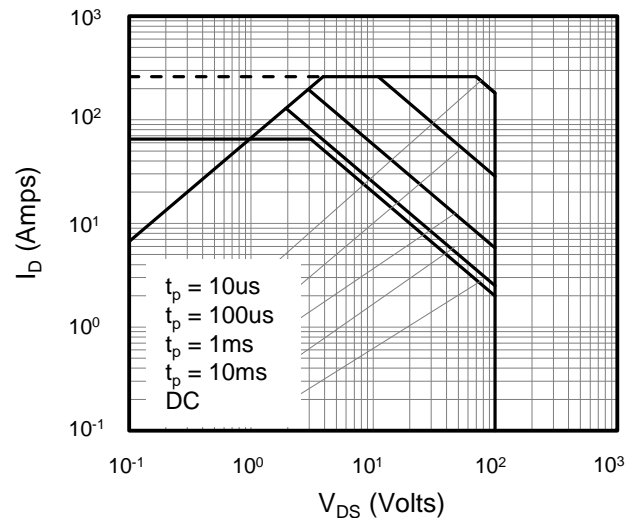


Figure 10: Safe Operating Area



Figure A: Gate Charge Test Circuit and Waveform



Figure B: Resistive Switching Test Circuit and Waveform

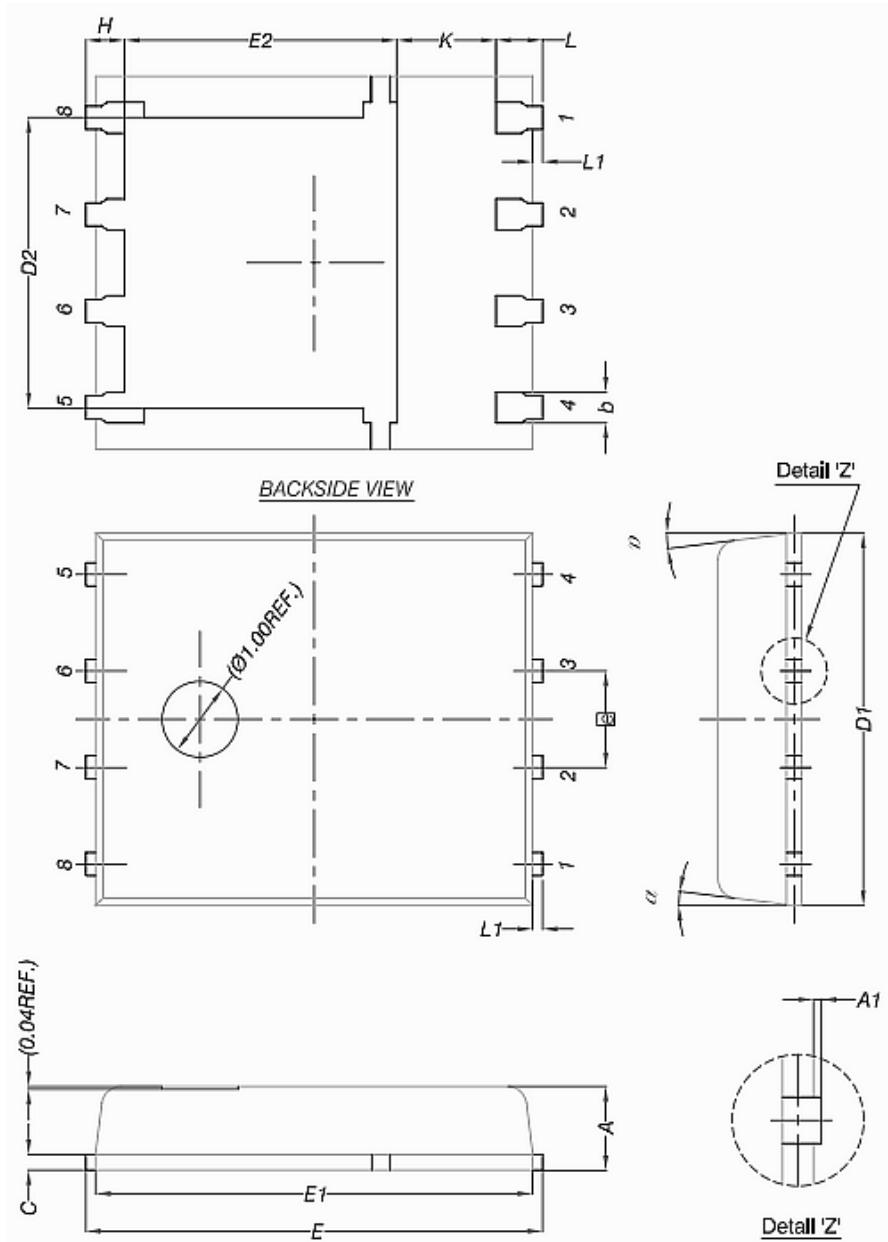


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





DFN 5*6



Unit:mm			
Symbol	Min.	Nom	Max.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80

Unit:mm			
Symbol	Min.	Nom	Max.
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
α	0°	-	12°



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